

P-Channel Enhancement Mode Power MOSFET

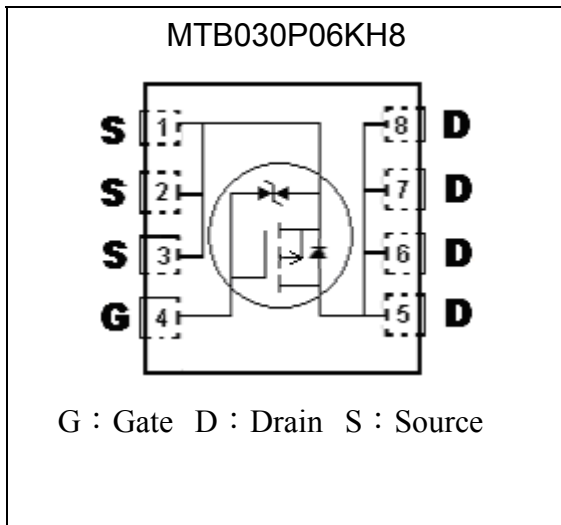
MTB030P06KH8

BV_{DSS}	-60V
I_D@V_{GS}=10V, T_C=25°C	-34A
I_D@V_{GS}=10V, T_A=25°C	-5.9A
R_{DS(ON)}@V_{GS}=-10V, I_D=-6A	21.4 mΩ (typ)
R_{DS(ON)}@V_{GS}=-4.5V, I_D=-4A	35.6 mΩ (typ)
R_{DS(ON)}@V_{GS}=-4V, I_D=-3A	42.6 mΩ (typ)

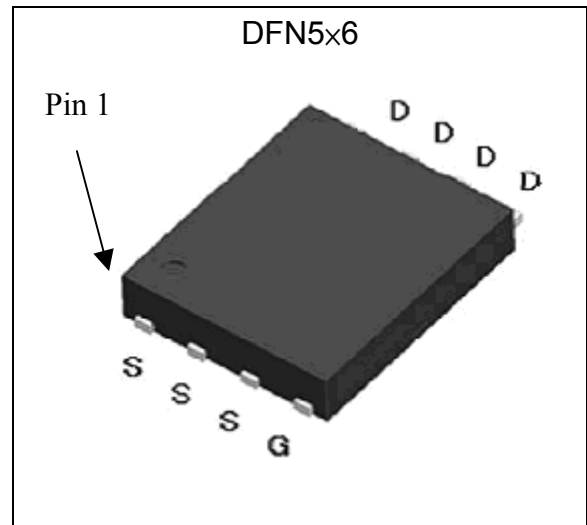
Features

- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- ESD protected gate
- RoHS compliant package

Symbol

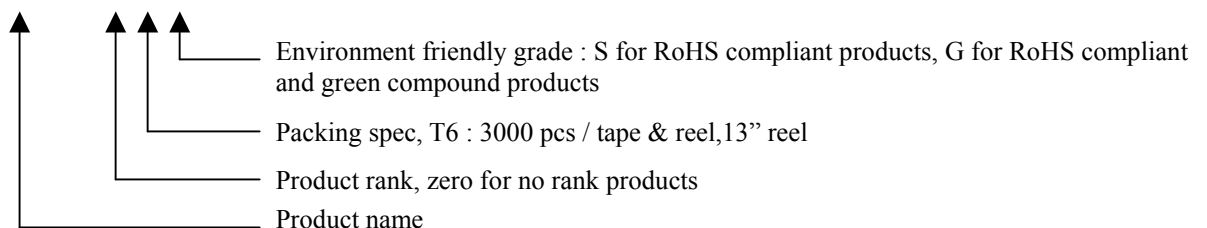


Outline



Ordering Information

Device	Package	Shipping
MTB030P06KH8-0-T6-G	DFN 5 x6 (Pb-free lead plating and halogen-free package)	3000 pcs / tape & reel



**Absolute Maximum Ratings** ($T_C=25^{\circ}\text{C}$)

Parameter	Symbol	Limits	Unit	
Drain-Source Voltage (Note 1)	V_{DS}	-60	V	
Gate-Source Voltage	V_{GS}	± 20		
Continuous Drain Current @ $T_C=25^{\circ}\text{C}$, $V_{GS}=-10\text{V}$ (Note 5)	I_D	-34*	A	
Continuous Drain Current @ $T_C=100^{\circ}\text{C}$, $V_{GS}=-10\text{V}$ (Note 5)		-24*		
Continuous Drain Current @ $T_A=25^{\circ}\text{C}$, $V_{GS}=-10\text{V}$ (Note 2)	I_{DSM}	-5.9		
Continuous Drain Current @ $T_A=70^{\circ}\text{C}$, $V_{GS}=-10\text{V}$ (Note 2)		-4.7		
Pulsed Drain Current (Note 3)	I_{DM}	-110*		
Avalanche Current (Note 3)	I_{AS}	-24		
Single Pulse Avalanche Energy @ $L=0.5\text{mH}$, $I_D=-24$ Amps, $V_{DD}=-15\text{V}$ (Note 4)	E_{AS}	144		mJ
Repetitive Avalanche Energy (Note 3)	E_{AR}	7.5		
Power Dissipation	P_D	$T_C=25^{\circ}\text{C}$ (Note 1)	W	
		$T_C=100^{\circ}\text{C}$ (Note 1)		75
	P_{DSM}	$T_A=25^{\circ}\text{C}$ (Note 2)		37.5
		$T_A=70^{\circ}\text{C}$ (Note 2)		2
Operating Junction and Storage Temperature	T_j, T_{stg}	-55~+175		

*Drain current limited by maximum junction temperature

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	2	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max (Note 2)	$R_{\theta JA}$	62	

- Note :
1. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
 2. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^{\circ}\text{C}$. The value in any given application depends on the user's specific board design. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C , and the maximum temperature of 175°C may be used if the PCB allows it.
 3. Pulse width limited by junction temperature $T_{J(\text{MAX})}=175^{\circ}\text{C}$.
 4. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^{\circ}\text{C}$. 100% tested by conditions of $V_{DD}=-15\text{V}$, $I_D=-12\text{A}$, $L=0.5\text{mH}$, $V_{GS}=-10\text{V}$.
 5. Calculated continuous drain current based on maximum allowable junction temperature.
 6. The static characteristics are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% maximum.
 7. The $R_{\theta JA}$ is the sum of thermal resistance from junction to case $R_{\theta JC}$ and case to ambient.

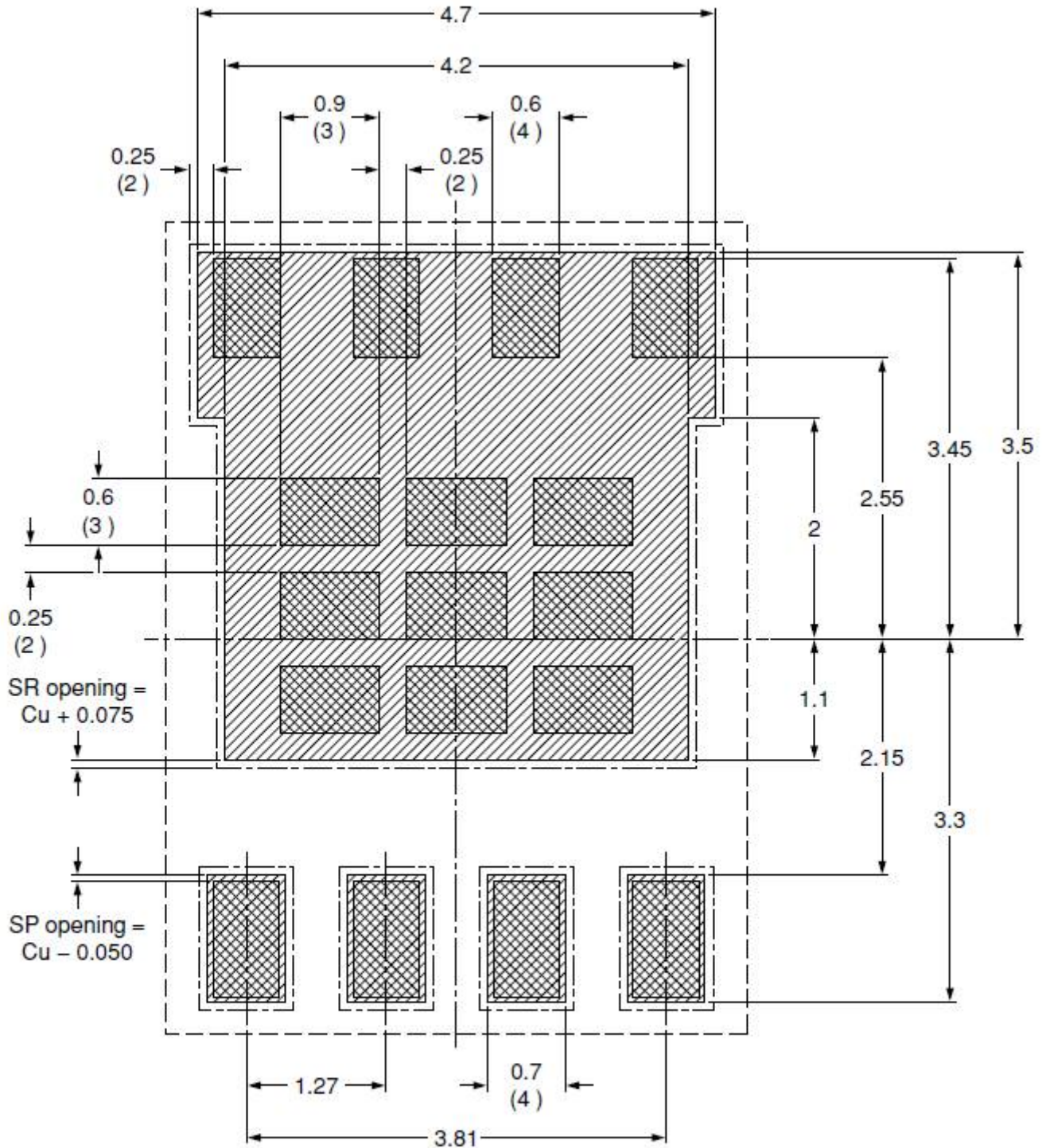


Characteristics (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-60	-	-	V	V _{GS} =0V, I _D =-250μA
ΔBV _{DSS} /ΔT _j	-	-36	-	mV/°C	Reference to 25°C, I _D =-250μA
V _{GS(th)}	-1	-	-2.5	V	V _{DS} = -10V, I _D = -1mA
*G _{FS}	-	17.3	-	S	V _{DS} = -5V, I _D = -10A
I _{GSS}	-	-	±10	μA	V _{GS} = ±16V
I _{DSS}	-	-	1		V _{DS} = -60V, V _{GS} = 0V
	-	-	5		V _{DS} = -48V, V _{GS} = 0V, T _j = 55°C
*R _{DS(ON)}	-	21.4	28	mΩ	V _{GS} = -10V, I _D = -6A
	-	35.6	47		V _{GS} = -4.5V, I _D = -4A
	-	42.6	56		V _{GS} = -4V, I _D = -3A
Dynamic					
*Q _g	-	28.5	-	nC	V _{DD} = -48V, I _D = -6A, V _{GS} = -10V
*Q _{gs}	-	4.9	-		
*Q _{gd}	-	8.4	-		
*t _{d(ON)}	-	14	-	ns	V _{DD} = -30V, I _D = -1A, V _{GS} = -10V, R _G = 6Ω
*t _r	-	18.8	-		
*t _{d(OFF)}	-	68.2	-		
*t _f	-	66.2	-		
C _{iss}	-	1453	-	pF	V _{GS} = 0V, V _{DS} = -20V, f = 1MHz
C _{oss}	-	218	-		
C _{rss}	-	120	-		
Source-Drain Diode					
*I _S	-	-	-34	A	
*I _{SM}	-	-	-110		
*V _{SD}	-	-0.78	-1.2	V	I _S = -6A, V _{GS} = 0V
*t _{rr}	-	15	-	ns	V _{GS} = 0V, I _F = -6A, dI _F /dt = 100A/μs
*Q _{rr}	-	8	-	nC	

*Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%

Recommended Soldering Footprint & Stencil Design



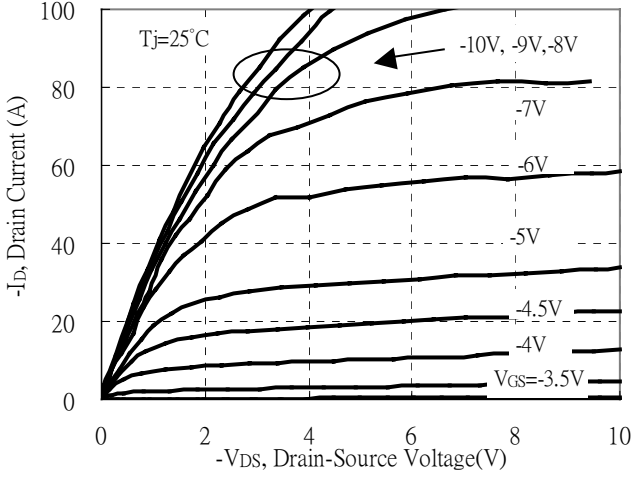
- | | |
|---|--|
|  solder lands |  solder paste
125 μm stencil |
|  solder resist |  occupied area |

unit : mm

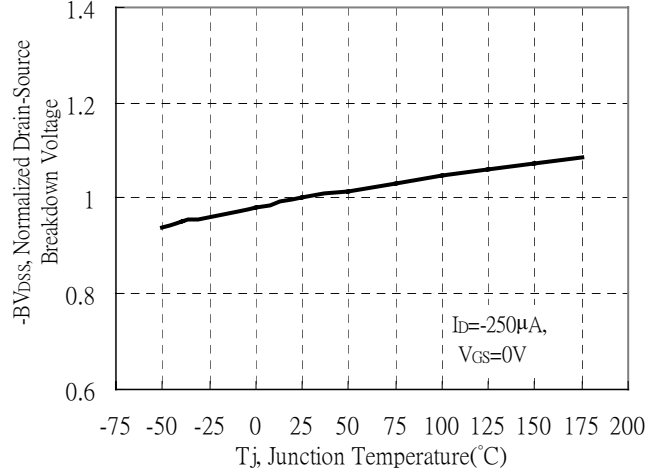


Typical Characteristics

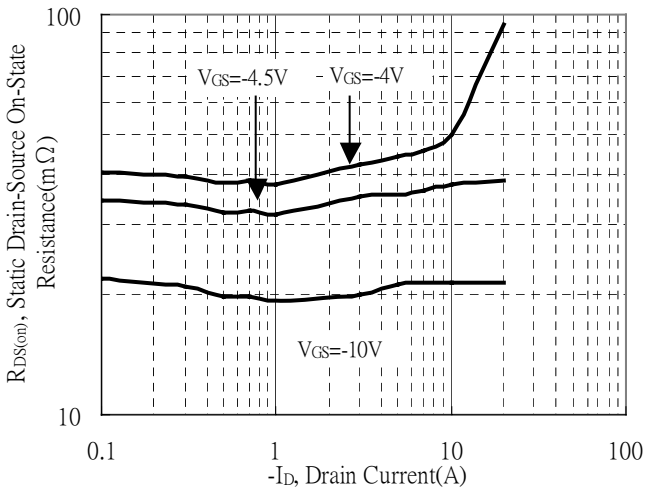
Typical Output Characteristics



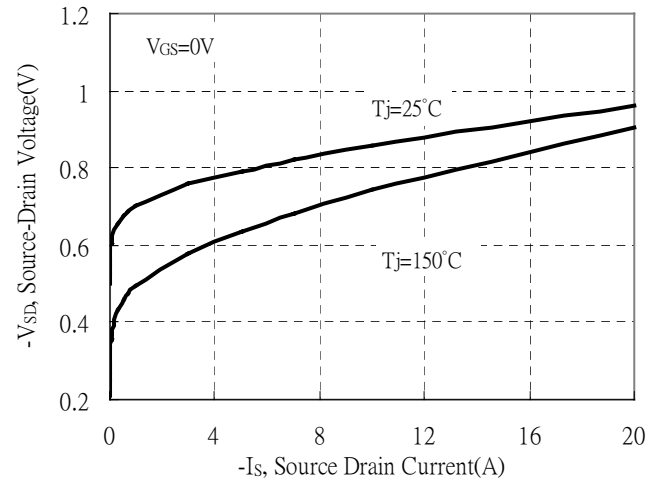
Normalized Brekdown Voltage vs Ambient Temperature



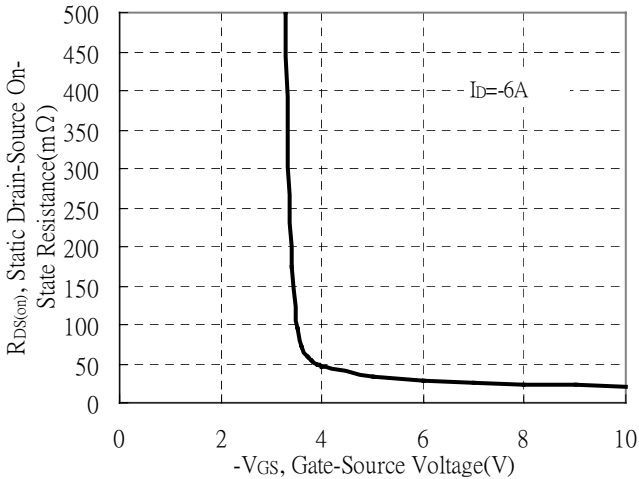
Static Drain-Source On-State resistance vs Drain Current



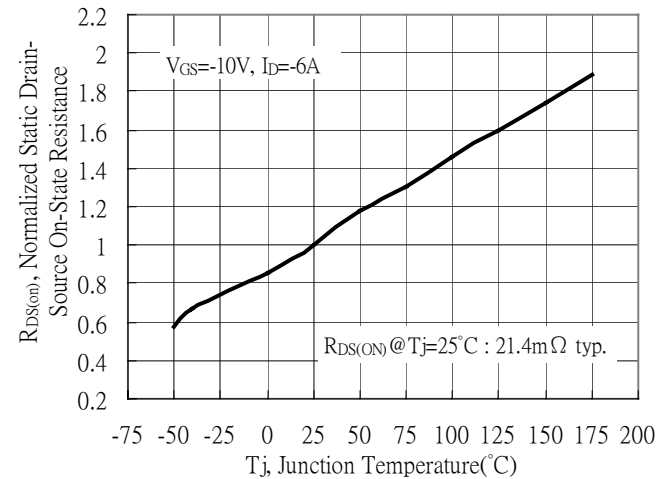
Source Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

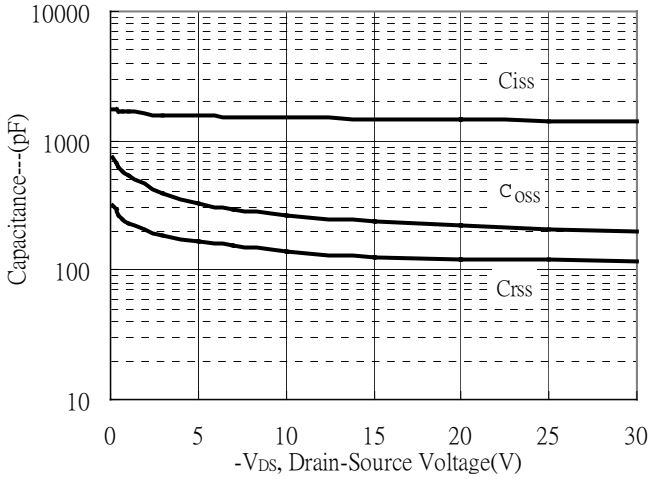


Normalized Drain-Source On-State Resistance vs Junction Temperature

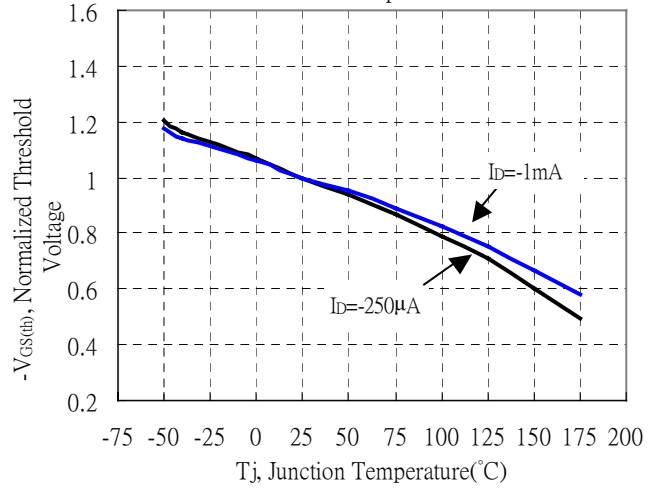


Typical Characteristics(Cont.)

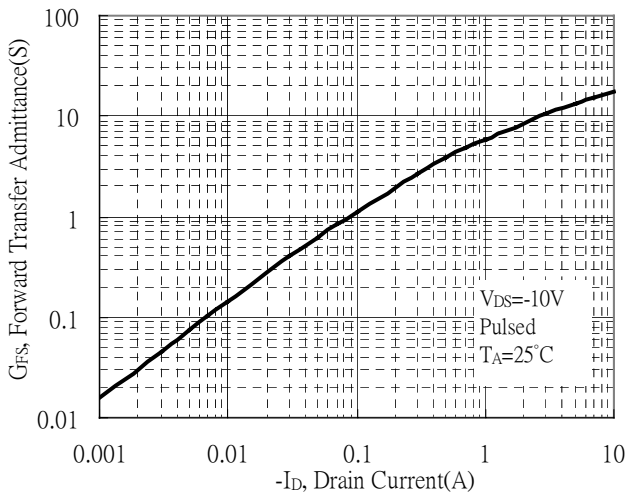
Capacitance vs Drain-to-Source Voltage



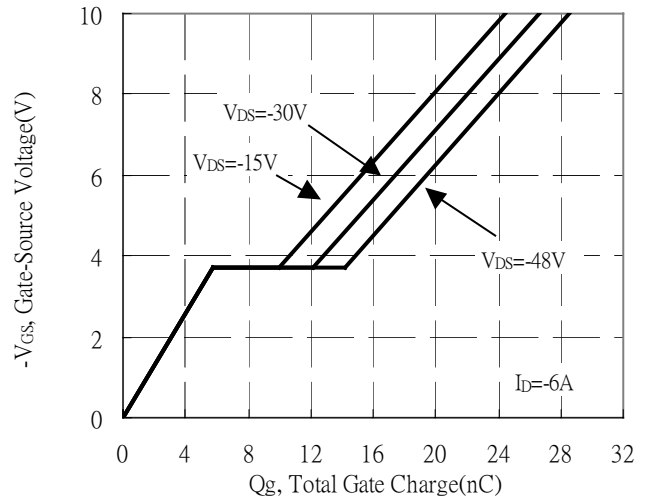
Normalized Threshold Voltage vs Junction Temperature



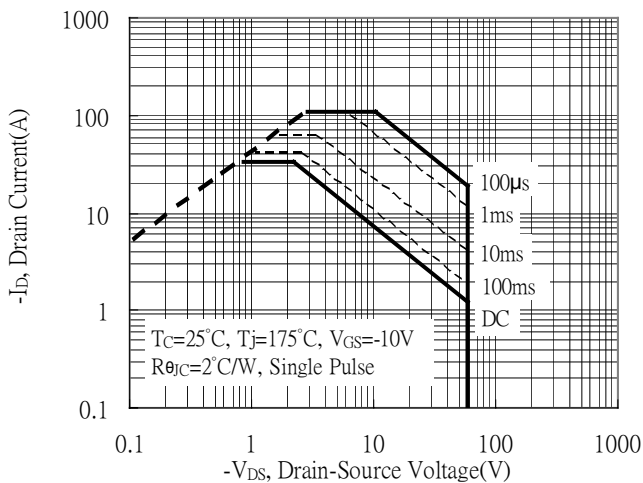
Forward Transfer Admittance vs Drain Current



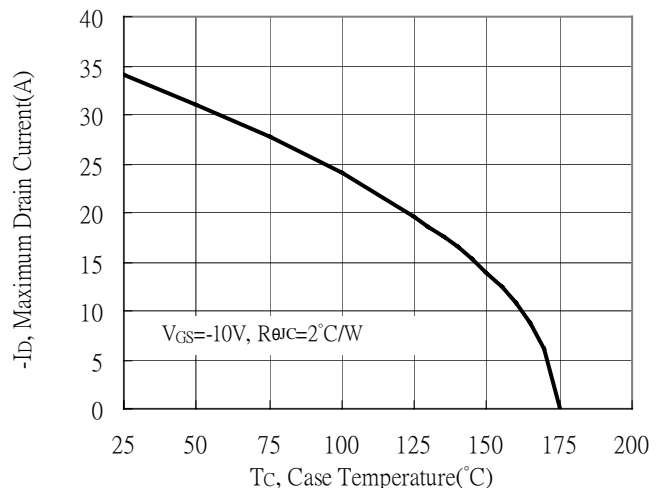
Gate Charge Characteristics



Maximum Safe Operating Area



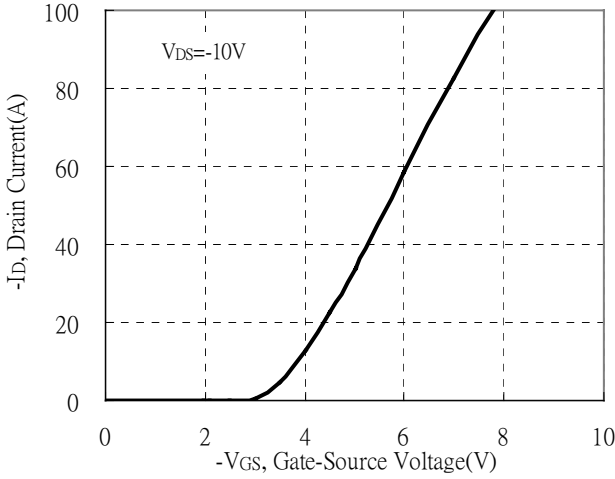
Maximum Drain Current vs Case Temperature



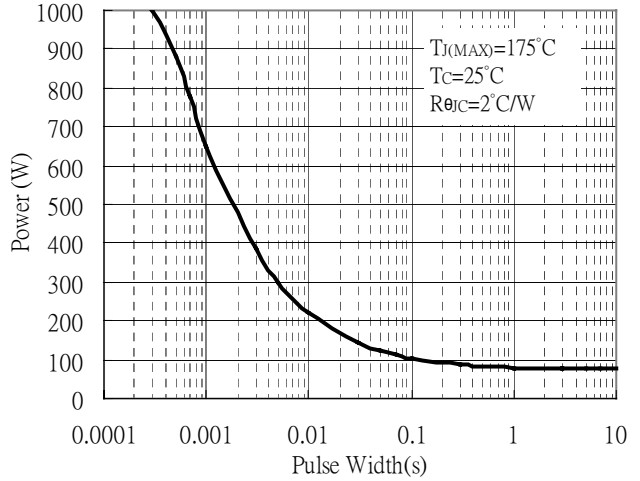


Typical Characteristics(Cont.)

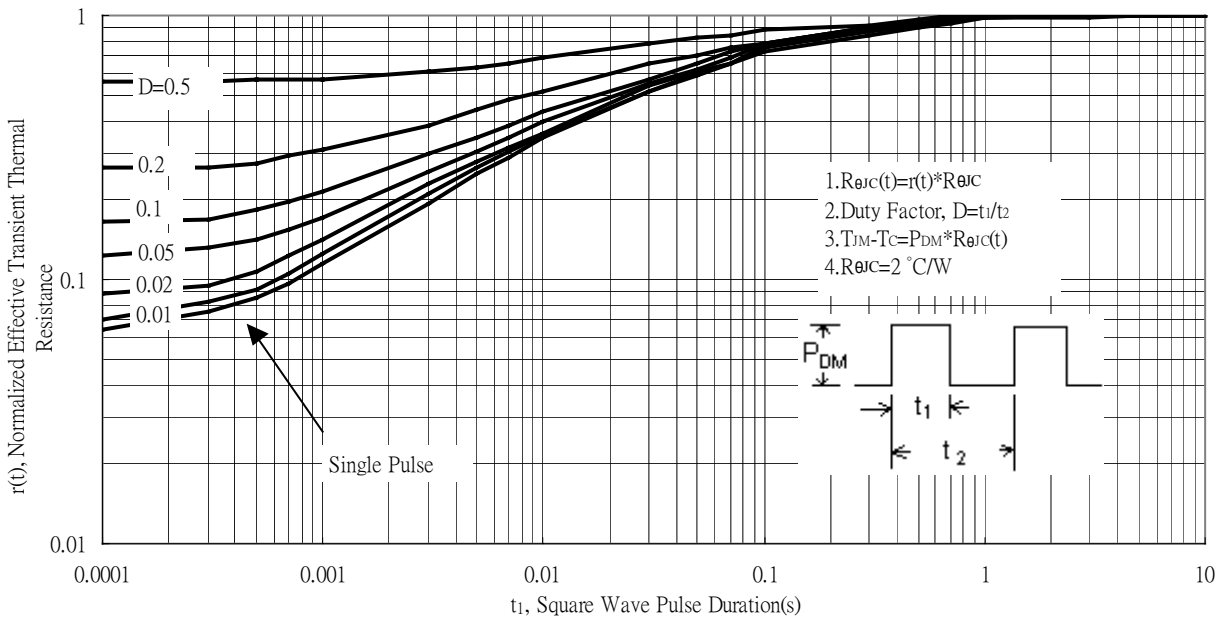
Typical Transfer Characteristics



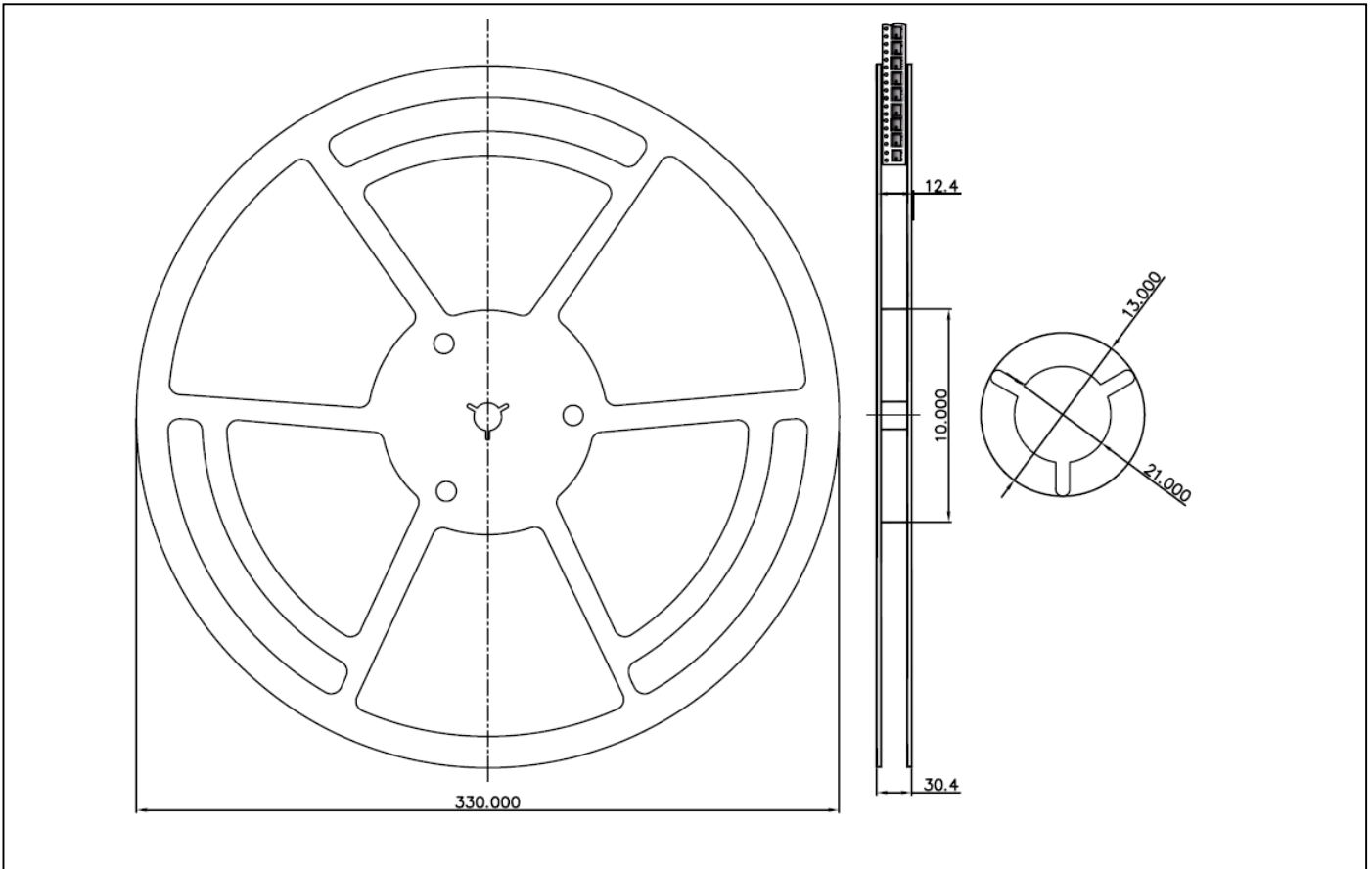
Single Pulse Power Rating, Junction to Case



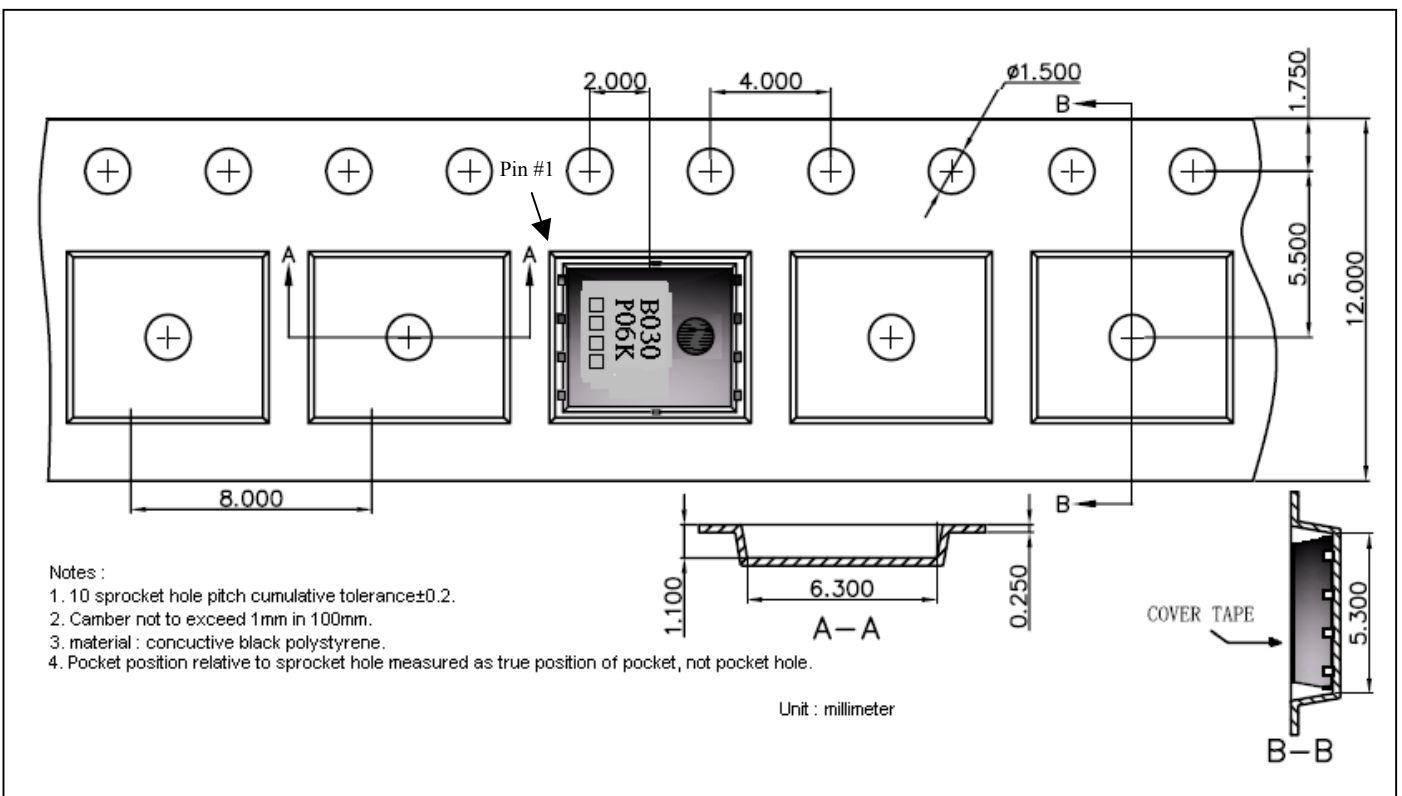
Transient Thermal Response Curves



Reel Dimension



Carrier Tape Dimension



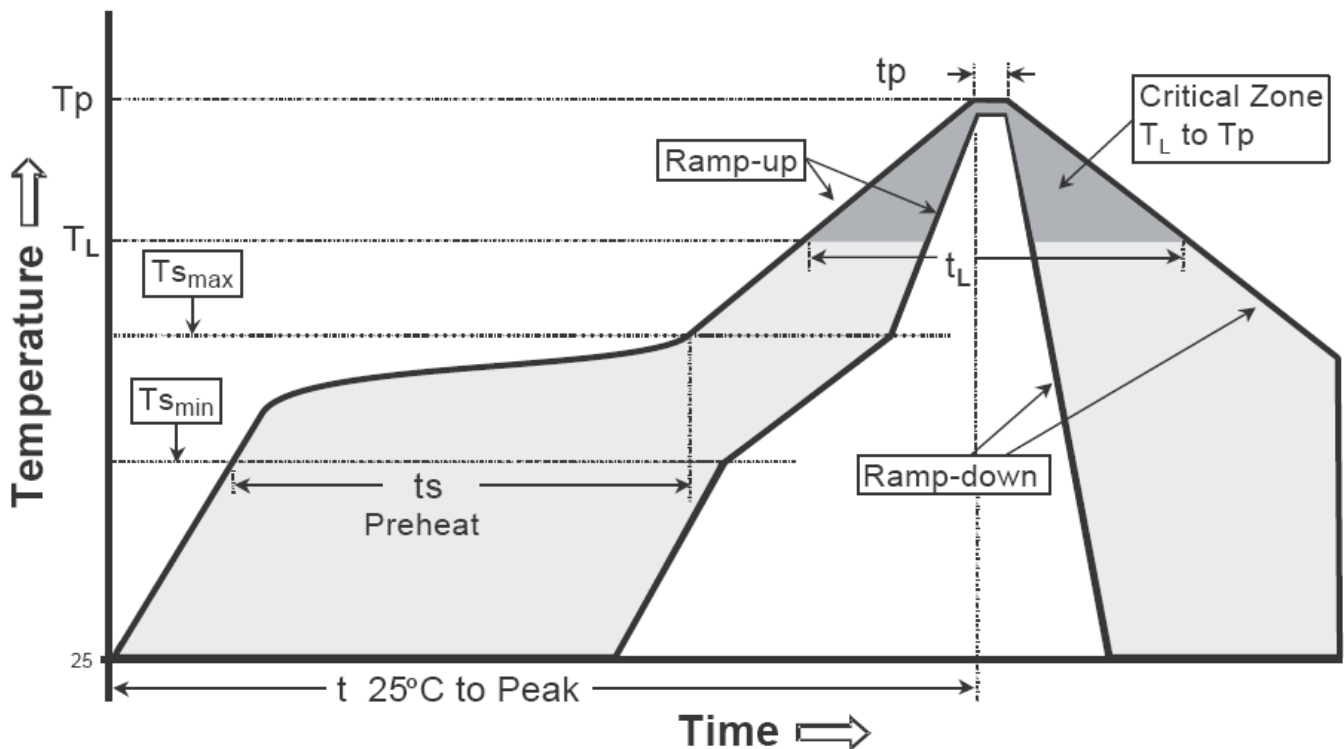
Notes :

1. 10 sprocket hole pitch cumulative tolerance±0.2.
2. Camber not to exceed 1mm in 100mm.
3. material : conductive black polystyrene.
4. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

Unit : millimeter

Recommended wave soldering condition

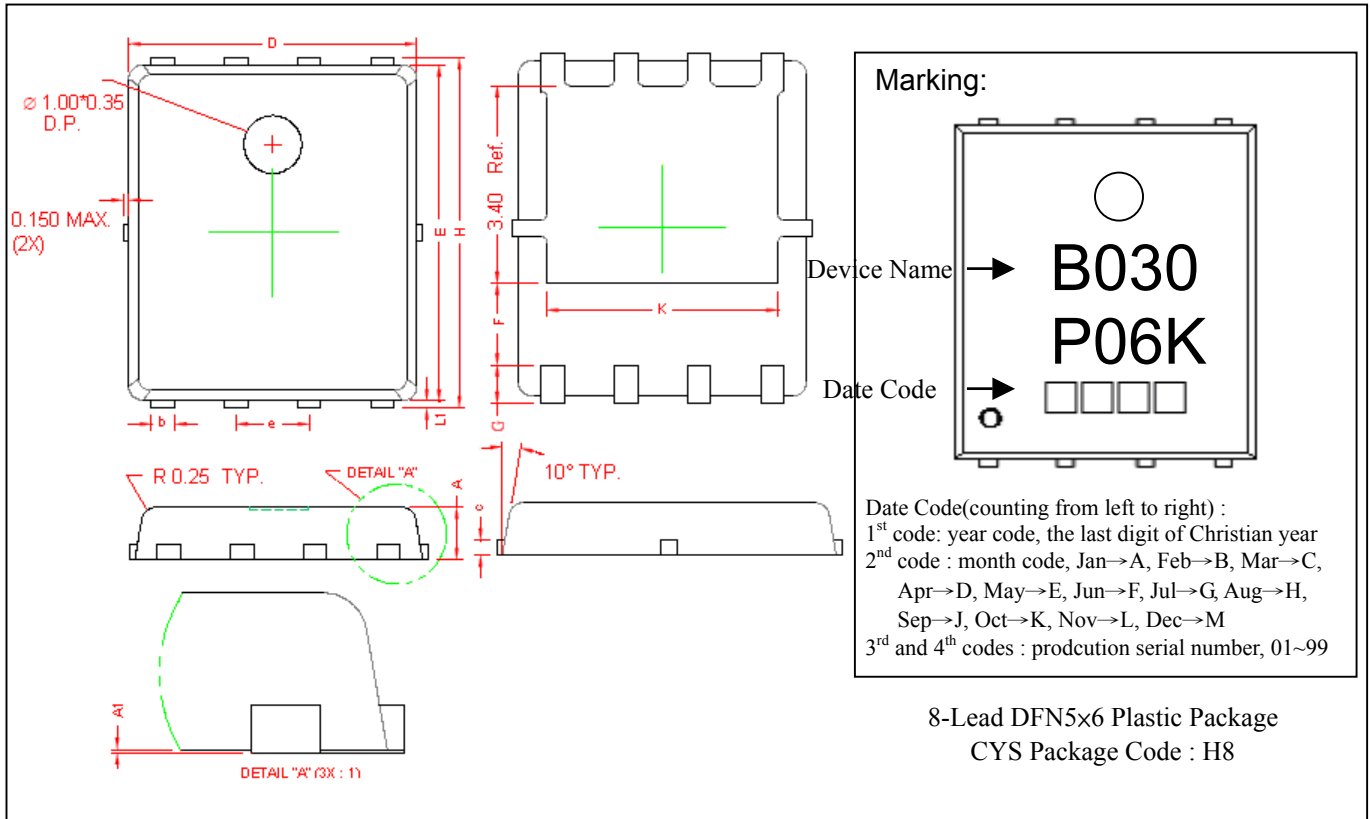
Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

Recommended temperature profile for IR reflow


Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

DFN5x6 Dimension



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.80	1.00	0.031	0.039	E	5.70	5.90	0.224	0.232
A1	0.00	0.05	0.000	0.002	e	1.27 BSC		0.050	BSC
b	0.35	0.49	0.014	0.019	H	5.95	6.20	0.234	0.244
c	0.254 REF		0.010 REF		L1	0.10	0.18	0.004	0.007
D	4.90	5.10	0.193	0.201	G	0.60 REF		0.024	REF
F	1.40 REF		0.055 REF		K	4.00 REF		0.157	REF

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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